## **Q1PACK Module**

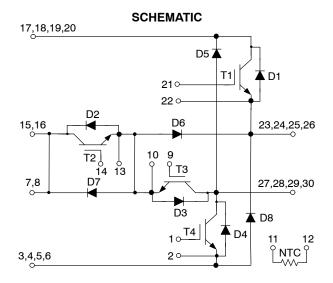
This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

#### **Features**

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Package with Press-Fit and Solder Pins

#### **Typical Applications**

- Solar Inverters
- Uninterruptable Power Supplies

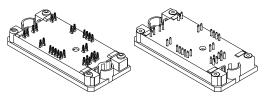




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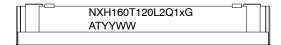
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#### **PACKAGE PICTURE**



Q1PACK CASE 180AD PRESS FIT Q1PACK CASE 180AQ SOLDER PINS

#### **DEVICE MARKING**

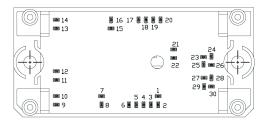


x = P or S

G = Pb-Free Package

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

#### **PIN ASSIGNMENTS**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 14 of this data sheet.

Table 1. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1, D4)			
Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Forward Current, DC @ T <sub>h</sub> = 80°C	I <sub>F</sub>	20	Α
Repetitive Peak Forward Current T <sub>pulse</sub> limited by T <sub>jmax</sub>	I <sub>FRM</sub>	80	Α
Power Dissipation per Diode $T_j = T_{jmax} \qquad \qquad T_h = 80^{\circ}C$	P <sub>tot</sub>	51	W
Maximum Junction Temperature	T <sub>J</sub>	150	°C
HALFBRIDGE IGBT (T1, T4)			
Collector-emitter voltage	V <sub>CES</sub>	1200	V
Collector current @ T <sub>h</sub> = 80°C	I <sub>C</sub>	140	А
Pulsed Collector Current, T <sub>pulse</sub> Limited by T <sub>jmax</sub>	I <sub>CM</sub>	480	А
Power Dissipation per IGBT $T_{j} = T_{jmax} \qquad \qquad T_{h} = 80^{\circ}C$	P <sub>tot</sub>	280	W
Gate-emitter voltage	$V_{GE}$	±20	V
Short Circuit Withstand Time $V_{GE} = 15 \text{ V}, V_{CE} = 600 \text{ V}, T_J \le 150^{\circ}\text{C}$	T <sub>SC</sub>	10	μs
Maximum Junction Temperature	T <sub>J</sub>	150	°C
NP DIODE (D6, D7)			
Peak Repetitive Reverse Voltage	$V_{RRM}$	650	V
Forward Current, DC @ T <sub>h</sub> = 80°C	I <sub>F</sub>	58	А
Repetitive Peak Forward Current, T <sub>pulse</sub> limited by T <sub>Jmax</sub>	I <sub>FRM</sub>	200	А
Power Dissipation Per Diode $T_j = T_{jmax}$ $T_h = 80^{\circ}C$	P <sub>tot</sub>	89	W
Maximum Junction Temperature	TJ	150	°C
NP IGBT (T2, T3)			
Collector-emitter voltage	V <sub>CES</sub>	650	V
Collector current @ T <sub>h</sub> = 80°C	I <sub>C</sub>	83	А
Pulsed collector current, T <sub>pulse</sub> limited by T <sub>Jmax</sub>	I <sub>CM</sub>	235	А
Power Dissipation Per IGBT $T_j = T_{jmax} \qquad T_h = 80^{\circ}C$	P <sub>tot</sub>	117	W
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Short Circuit Withstand Time $V_{GE}$ = 15 V, $V_{CE}$ = 400 V, $T_{J}$ $\leq$ 150°C	T <sub>sc</sub>	5	μs
Maximum Junction Temperature	TJ	150	°C
NP INVERSE DIODE (D2, D3)			
Peak Repetitive Reverse Voltage	$V_{RRM}$	650	V
Forward Current, DC @ T <sub>h</sub> = 80°C	I <sub>F</sub>	17	А
Repetitive Peak Forward Current, $T_{\text{pulse}}$ limited by $T_{\text{Jmax}}$	I <sub>FRM</sub>	68	Α
Power Dissipation Per Diode $T_j = T_{jmax} \qquad T_h = 80^{\circ}C$	P <sub>tot</sub>	28	W
Maximum Junction Temperature	TJ	150	°C
HALFBRIDGE DIODE (D5, D8)			
Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Forward Current, DC @ T <sub>h</sub> = 80°C (per diode)	I <sub>F</sub>	45	А
Repetitive Peak Forward Current, T <sub>pulse</sub> limited by T <sub>Jmax</sub>	I <sub>FRM</sub>	180	А
Power Dissipation Per Diode $T_j = T_{jmax} \qquad T_h = 80^{\circ}C$	P <sub>tot</sub>	78	W
			•

**Table 1. ABSOLUTE MAXIMUM RATINGS** 

Rating	Symbol	Value	Unit
HALFBRIDGE DIODE (D5, D8)			
Junction Temperature	T <sub>J</sub>	150	°C
THERMAL PROPERTIES			
Operating Temperature under switching condition	T <sub>VJ OP</sub>	-40 to (T <sub>jmax</sub> -25)	°C
Storage Temperature range	T <sub>stg</sub>	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60 Hz/50 Hz	V <sub>is</sub>	3000	$V_{RMS}$
Creepage distance		12.7	mm
Clearance		8.06	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1	, D4) CHARACTERISTICS					
Forward voltage	$I_F = 7 \text{ A}, T_j = 25^{\circ}\text{C}$ $I_F = 7 \text{ A}, T_j = 125^{\circ}\text{C}$	V <sub>F</sub>	- -	1.46 1.49	2.7 _	V
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	R <sub>thJH</sub>		1.864		°C/W
HALFBRIDGE IGBT (T1, T4) CHARACTE	RISTICS					
Collector-emitter saturation voltage	$V_{GE}$ = 15 V, $I_{C}$ = 160 A, $T_{j}$ = 25°C $V_{GE}$ = 15 V, $I_{C}$ = 160 A, $T_{j}$ = 125°C	V <sub>CE(sat)</sub>	_ _	2.06 2.10	2.50 –	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$ , $I_C = 6 \text{ mA}$	V <sub>GE(TH)</sub>	5.0	5.80	6.50	V
Collector-emitter cutoff current	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}$	I <sub>CES</sub>	=	_	800	μΑ
Gate leakage current	$V_{GE}$ = 20 V, $V_{CE}$ = 0 V	I <sub>GES</sub>	П	_	800	nA
Turn-on delay time	T <sub>j</sub> = 125°C	t <sub>d(on)</sub>	_	55	_	ns
Rise time	$V_{CE} = 350 \text{ V}, I_{C} = 100 \text{ A}$	t <sub>r</sub>	I	50	_	
Turn-off delay time	$V_{GE}$ = ±15 V, $R_G$ = 4 $\Omega$	t <sub>d(off)</sub>	ı	430	_	
Fall time		t <sub>f</sub>	_	105	_	
Turn on switching loss		E <sub>on</sub>	-	2.73	_	mJ
Turn off switching loss		E <sub>off</sub>	=	3.58	_	
Input capacitance	$V_{CE}$ =25 V. $V_{GE}$ = 0 V. f = 10 kHz	C <sub>ies</sub>	I	38164	_	pF
Output capacitance		C <sub>oes</sub>	П	644	_	
Reverse transfer capacitance		C <sub>res</sub>	1	784	_	
Gate charge total	$V_{CE}$ = 600 V, $I_{C}$ = 160 A, $V_{GE}$ = 15 V	$Q_g$		1664	_	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	R <sub>thJH</sub>		0.337		°C/W
NP DIODE (D6, D7) CHARACTERISTICS						
Forward voltage	$V_{GE} = 0 \text{ V, } I_F = 150 \text{ A, } T_j = 25^{\circ}\text{C}$ $V_{GE} = 0 \text{ V, } I_F = 150 \text{ A, } T_j = 125^{\circ}\text{C}$	V <sub>F</sub>	-	2.15 2.36	2.60 -	V
Reverse leakage current	V <sub>CE</sub> = 650 V, V <sub>GE</sub> = 0 V	lr	-	_	200	μΑ
Reverse recovery time	T <sub>j</sub> = 125°C	trr		225		ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, I_{C} = 100 \text{ A}$	Qrr		6.15	_	μC
Peak reverse recovery current	$V_{GE}$ = ±15 V, $R_{G}$ = 4 $\Omega$	Irrm	ı	85	_	Α
Peak rate of fall of recovery current		di/dtmax	=	1315	_	A/μs
Reverse recovery energy		Err	_	1.336		mJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	RthJH	=	1.07	-	°C/W
			_	_		_

**Table 2. ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
NP IGBT (T2, T3)						
Collector-emitter saturation voltage	$V_{CE}$ = 15 V, $I_{C}$ = 150 A, $T_{j}$ = 25°C $V_{CE}$ = 15 V, $I_{C}$ = 150 A, $T_{j}$ = 125°C	V <sub>CE(sat)</sub>	- -	1.65 1.84	2.0	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$ , $I_C = 8 \text{ mA}$	V <sub>GE(TH)</sub>	5.0	6.10	6.90	V
Collector-emitter cutoff current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 650 V	I <sub>CES</sub>	-	_	400	μΑ
Gate leakage current	V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	-	_	800	nA
Turn-on delay time	T <sub>j</sub> = 125°C	t <sub>d(on)</sub>	=	46	=	ns
Rise time	$V_{CE} = 350 \text{ V}, I_{C} = 100 \text{ A}$	t <sub>r</sub>	-	48	_	
Turn-off delay time	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	t <sub>d(off)</sub>	-	250	-	
Fall time		t <sub>f</sub>	-	105	_	
Turn on switching loss		E <sub>on</sub>	-	1.245	_	mJ
Turn off switching loss		E <sub>off</sub>	-	2.525	_	
Input capacitance	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 10 \text{ kHz}$	C <sub>ies</sub>	-	19380	-	pF
Output capacitance		C <sub>oes</sub>	-	570	-	
Reverse transfer capacitance		C <sub>res</sub>	-	496	-	
Gate charge total	V <sub>CE</sub> = 480 V, I <sub>C</sub> = 150 A, V <sub>GE</sub> = 15 V	$Q_g$	-	790	-	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	R <sub>thJH</sub>	-	0.81	=	°C/W
NP INVERSE DIODE (D2, D3)						
Forward voltage	$V_{GE} = 0 \text{ V, } I_F = 15 \text{ A, } T_j = 25^{\circ}\text{C}$ $V_{GE} = 0 \text{ V, } I_F = 15 \text{ A, } T_j = 125^{\circ}\text{C}$	V <sub>F</sub>	- -	1.60 1.59	2.20	V
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	R <sub>thJH</sub>		3.43		°C/W
HALFBRIDGE DIODE (D5, D8)						
Forward voltage	$V_{GE}$ = 0 V, $I_F$ = 150 A, $T_j$ = 25°C $V_{GE}$ = 0 V, $I_F$ = 150 A, $T_j$ = 125°C	V <sub>F</sub>	- -	2.50 2.80	3.50	V
Reverse leakage current	V <sub>CE</sub> = 1200 V, V <sub>GE</sub> = 0 V	lr	=	_	200	μΑ
Reverse recovery time	T <sub>j</sub> = 125°C	trr	=	405	_	ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, I_{C} = 100 \text{ A}$	Qrr	=	15.5	_	μС
Peak reverse recovery current	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	Irrm	=	220	_	Α
Peak rate of fall of recovery current		di/dtmax	=	5440	_	A/μs
Reverse recovery energy		Err	=	5.225	_	mJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda$ = 1 W/mK	RthJH	-	1.213	-	°C/M
THERMISTOR CHARACTERISTICS		•				
Nominal resistance		R <sub>25</sub>	_	22	-	kΩ
Nominal resistance	T = 100°C	R <sub>100</sub>	-	1486	-	Ω
Deviation of R25		DR/R	-5	_	5	%
Power dissipation		$P_{D}$	-	200	-	mW
Power dissipation constant			_	2	-	mW/k
B-value	B(25/50), tol ±3%		-	3950	-	K
B-value	B(25/100), tol ±3%		_	3998	_	K

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

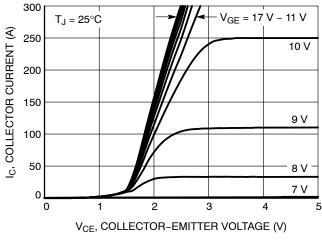


Figure 1. Typical Output Characteristics

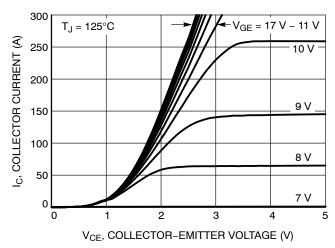


Figure 2. Typical Output Characteristics

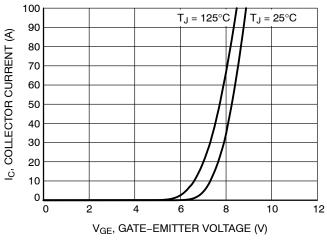


Figure 3. Typical Transfer Characteristics

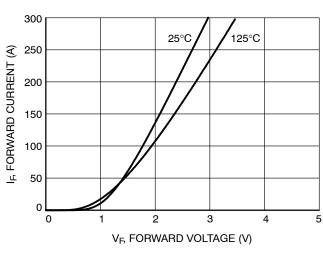


Figure 4. Diode Forward Characteristics

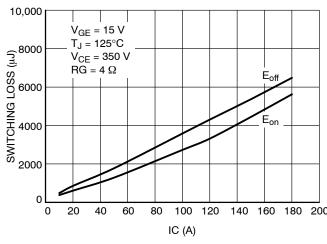


Figure 5. Typical Switching Loss vs. IC

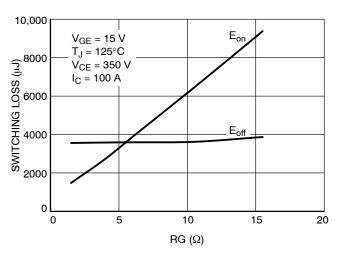
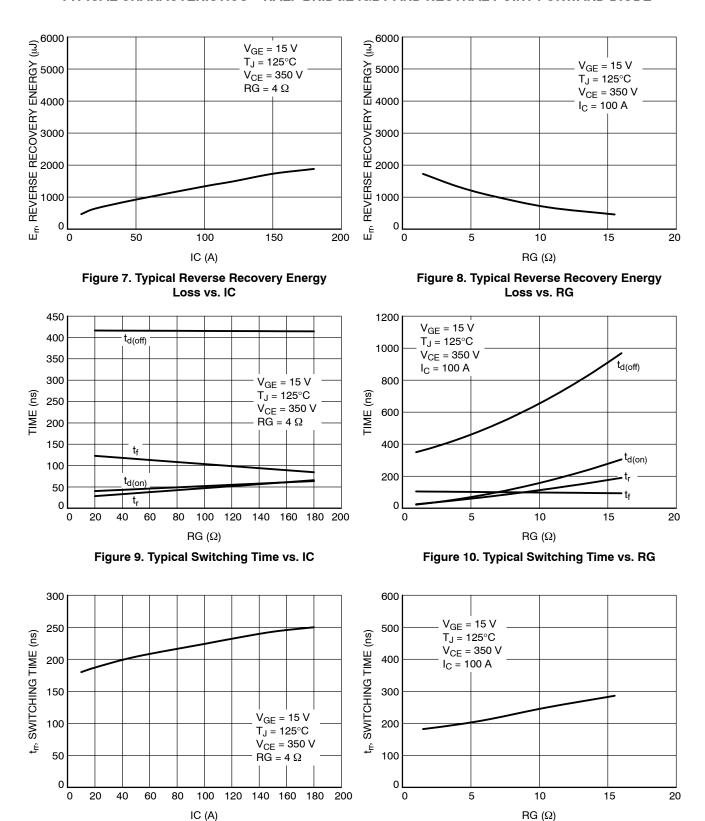


Figure 6. Typical Switching Loss vs. RG

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

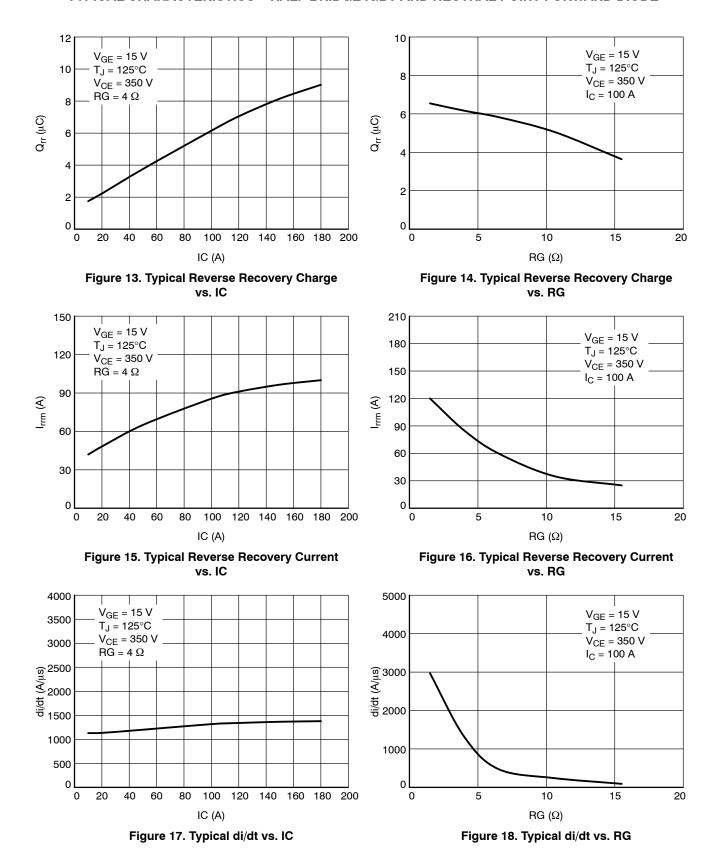


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Figure 12. Typical Reverse Recovery Time vs. RG

Figure 11. Typical Reverse Recovery Time vs.

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE



#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

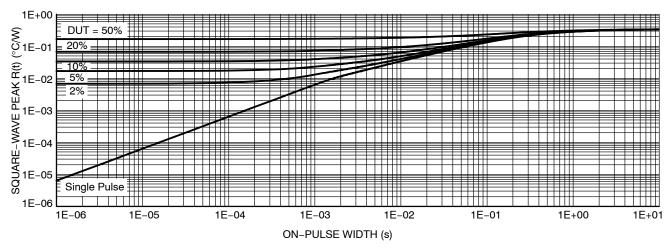


Figure 19. Transient Thermal Impedance (Half Bridge IGBT)

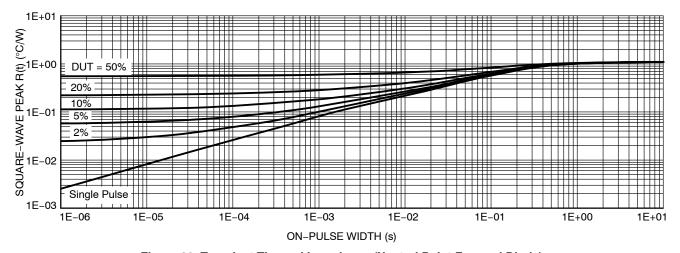


Figure 20. Transient Thermal Impedance (Neutral Point Forward Diode)

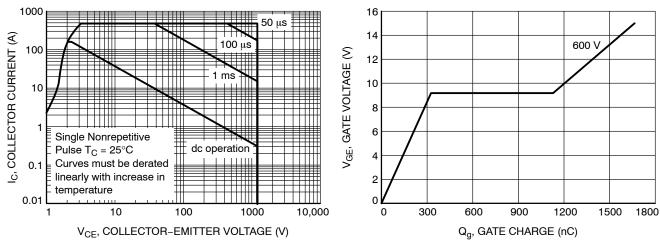
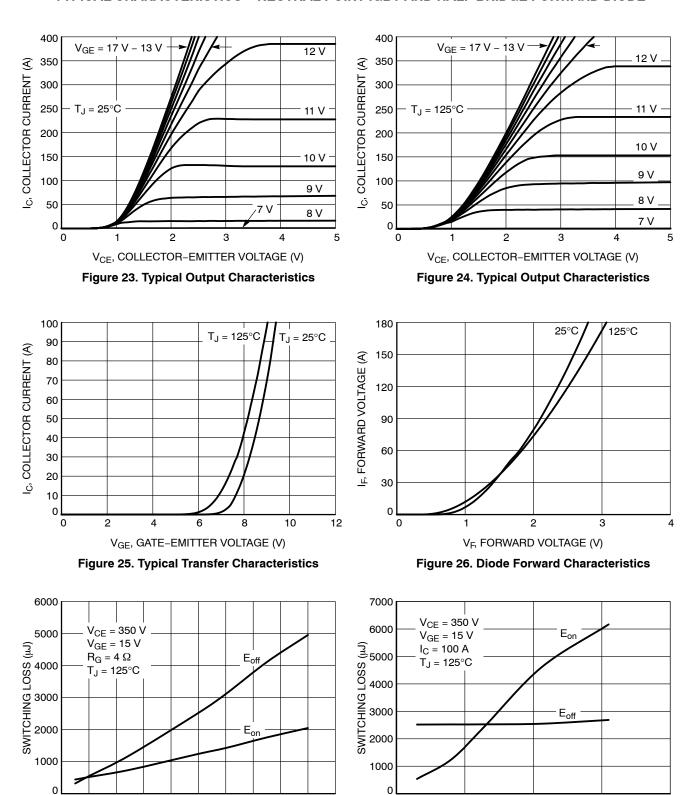


Figure 21. Safe Operating Area

Figure 22. Gate Voltage vs. Gate Charge

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE



IC (A) Figure 27. Typical Switching Loss vs. IC

120

140 160 180 200

20 40

60

80 100

 $\label{eq:RG} \text{RG }(\Omega)$  Figure 28. Typical Switching Loss vs. RG

10

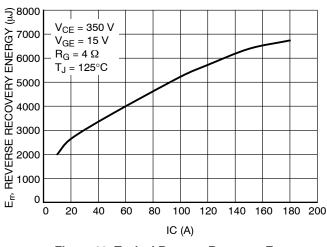
15

20

0

5

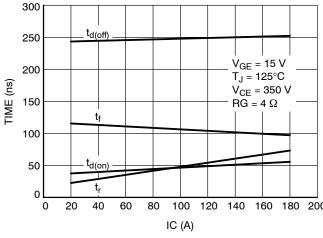
#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE



3 8000 5 7000 W GE = 350 V V<sub>GE</sub> = 15 V I<sub>C</sub> = 100 A T<sub>J</sub> = 125°C

Figure 29. Typical Reverse Recovery Energy Loss vs. IC

Figure 30. Typical Reverse Recovery Energy Loss vs. RG



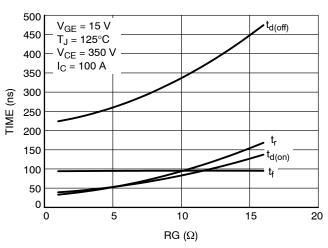
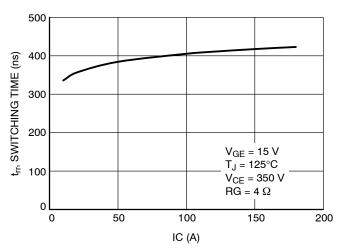


Figure 31. Typical Switching Time vs. IC

Figure 32. Typical Switching Time vs. RG



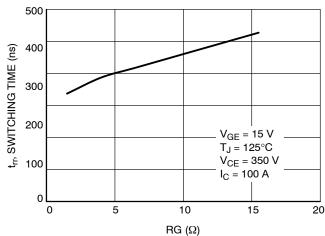
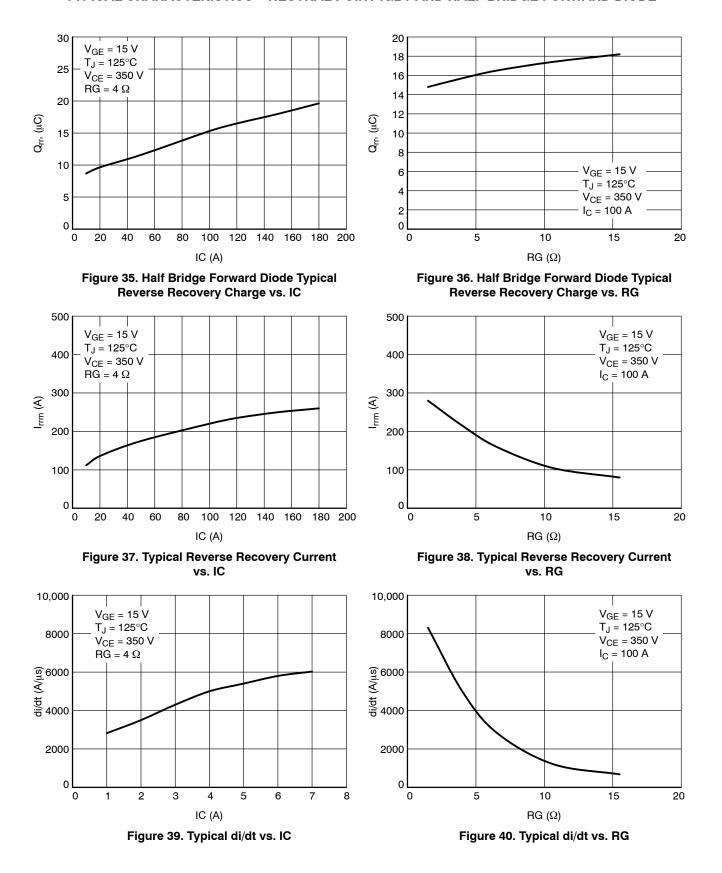


Figure 33. Half Bridge Forward Diode Typical Reverse Recovery Time vs. IC

Figure 34. Half Bridge Forward Diode Typical Reverse Recovery Time vs. RG

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE



#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE

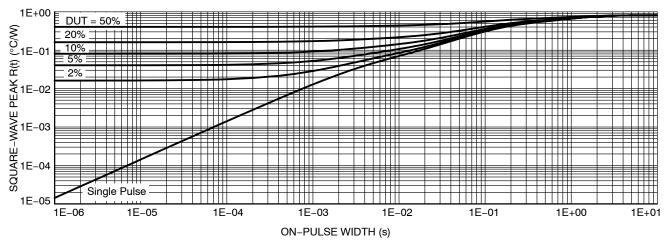


Figure 41. Transient Thermal Impedance (Neutral Point IGBT)

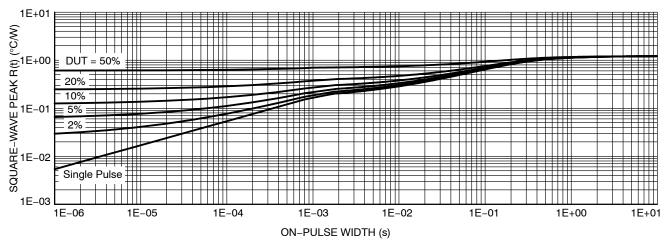


Figure 42. Transient Thermal Impedance (Half Bridge Forward Diode)

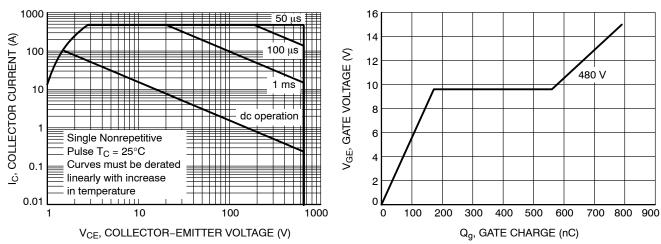


Figure 43. Safe Operating Area

Figure 44. Gate Voltage vs. Gate Charge

#### TYPICAL CHARACTERISTICS - HALF BRIDGE INVERSE DIODE

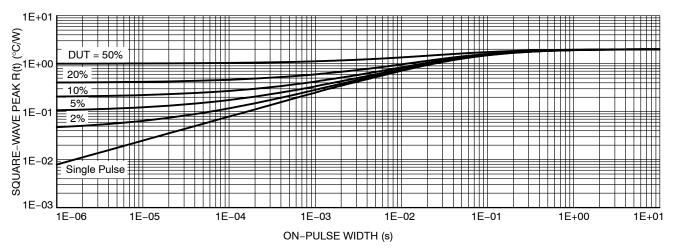


Figure 45. Transient Thermal Impedance

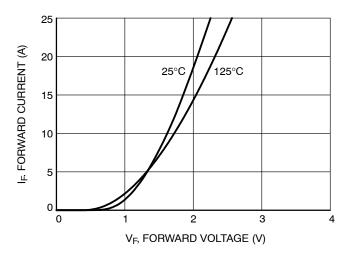


Figure 46. Diode Forward Characteristics

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT INVERSE DIODE

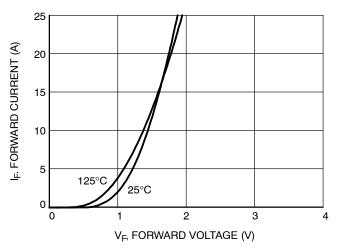


Figure 47. Diode Forward Characteristics

#### TYPICAL CHARACTERISTICS - THERMISTOR

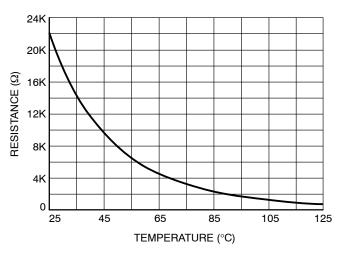


Figure 48. Thermistor Characteristics

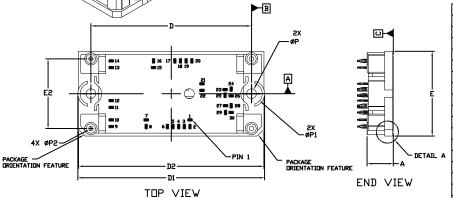
#### **ORDERING INFORMATION**

Orderable Part Number	Package	Shipping
NXH160T120L2Q1PG (Press Fit)	Q1PACK - Case 180AD (Pb-Free and Halide-Free)	21 Units / Blister Tray
NXH160T120L2Q1SG (Solder Pin)	Q1PACK - Case 180AQ (Pb-Free and Halide-Free)	21 Units / Blister Tray

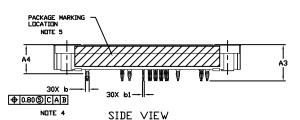


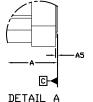


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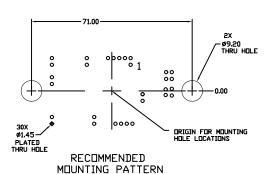


MOUNTING HOLE POSITION			Ш	MOUNTING HOLE POSITIO		
PIN	х	Y	Ш	PIN	X	
1	8.30	11.55		16	-7.800	-14.50
a	8.30	14.50		17	1.60	-14.50
з	5.80	14.50		18	4.10	-14.50
4	3.30	14.50		19	6.60	-14.50
5	0.80	14.50		20	9.10	-14.50
6	-1.70	14.50		21	13.60	-4.40
7	-11.05	11.55		22	13.60	-1.45
8	-11.05	14.50		23	23.80	-1.80
9	-26.50	14.50		24	26.50	-2.05
10	-26.50	11.55		25	23.80	0170
11	-26.50	6.05		26	26.50	0.95
12	-26.50	3.05		27	24.00	5.30
13	-26.50	-11.55		28	26.50	5.30
14	-26.50	-14.50		29	24.00	8.30
15	-7.80	-11.55		30	26.50	8.30





NOTE 4



	MILLIM	MILLIMETERS					
DIM	MIN.	NDM.					
Α	11.10	12.10					
A3	15.50	16.50					
A4	12.88	BSC					
A5	0.00	0.45					
b	1.61	1.71					
b1	0.75	0.85					
D	70.50	71.50					
D1	82.00	83.00					
D2	81.50	82.50					
E	36.90	37.90					
E2	30.30	31.30					
Р	4.30	4.50					
P1	9.30	9.70					
P2	1.90	2.10					

	PIN POSITION		П		PIN P	NDITIZE	
PIN	х	Y	Ш	PIN	X	Y	
1	8.30	-11.55	П	16	-7.800	14.50	
2	8.30	-14.50	H	17	1.60	14.50	
3	5.80	-14.50	l	18	4.10	14.50	
4	3.30	-14.50	H	19	6.60	14.50	
5	0.80	-14.50		20	9.10	14.50	
6	-1.70	-14.50	H	21	13.60	4.40	
7	-11.05	-11.55		22	13.60	1.45	
8	-11.05	-14.50	H	23	23.80	1.80	
9	-26.50	-14.50		24	26.50	2.05	
10	-26.50	-11.55	H	25	23.80	-0.70	
11	-26.50	-6.05		26	26.50	-0.95	
12	-26.50	-3.05	H	27	24.00	-5.30	
13	-26.50	11.55		28	26.50	-5.30	
14	-26.50	14.50	l	29	24.00	-8.30	
15	-7.80	11.55	H	30	26.50	-8.30	

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS 6 AND 61 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.

(VIEW FROM MOUNTING SIDE)

- 4. POSITION OF THE CENTER OF THE TERMINALS
  IS DETERMINED FROM DATUM B THE CENTER OF
  DIMENSION D, X DIRECTION, AND FROM DATUM A,
  Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED
  IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH
  DIRECTIONS.
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

# GENERIC MARKING DIAGRAM\*

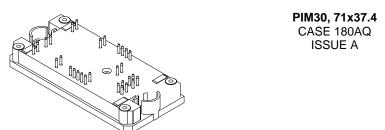
XXXXX = Specific Device Code G = Pb-Free Package

AT = Assembly & Test Site Code

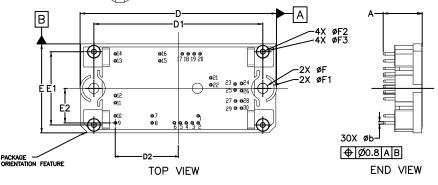
YYWW = Year and Work Week Code
\*This information is generic. Please refer to device data
sheet for actual part marking. Pb-Free indicator, "G" or
microdot" •", may or may not be present. Some products
may not follow the Generic Marking.

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DESCRIPTION:	PIM30 71X37.4 (PRESS FIT	ָרָ ה	PAGE 1 OF 1		

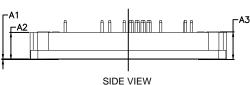
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DATE 25 JUN 2018



MOUNTING	HOLE PO	DSITION	MOUNTING	HOLE PO	DSITION
PIN	х	Y	PIN	х	Y
1	8.30	11.55	16	-7.800	-14.50
2	8.30	14.50	17	1.60	-14.50
3	5.80	14.50	18	4.10	-14.50
4	3.30	14.50	19	6.60	-14.50
5	0.80	14.50	20	9.10	-14.50
6	-1.70	14.50	21	13.60	-4.40
7	-11.05	11.55	22	13.60	-1.45
8	-11.05	14.50	23	23.80	-1.80
9	-26.50	14.50	24	26.50	-2.05
10	-26.50	11.55	25	23.80	0.70
11	-26.50	6.05	26	26.50	0.95
12	-26.50	3.05	27	24.00	5.30
13	-26.50	-11.55	28	26.50	5.30
14	-26.50	-14.50	29	24.00	8.30
15	-7.80	-11.55	30	26.50	8.30



#### MILLIMETERS NOM. DIM 16.40 16.90 15.90 A1 0.30 0.60 10.90 11.40 11.90 A2 11.10 11.60 12.10 A3 0.90 1.00 1.10 b D 82.00 82.50 83.00 D1 70.50 71.00 71.50 26.50 REF D2 36.90 37.40 37.90 F E1 30.30 30.80 31.30 14.50 REF E2 4.30 4.50 F F1 9.5 REF 2.0 REF F2 5.5 REF F3

NOTE 4						
	PIN POSITION				PIN PC	SITION
PIN	×	Y		PIN	х	Y
1	8.30	-11.55		16	-7.800	14.50
2	8.30	-14.50		17	1.60	14.50
3	5.80	-14.50		18	4.10	14.50
4	3.30	-14.50		19	6.60	14.50
5	0.80	-14.50		20	9.10	14.50
6	-1.70	-14.50		21	13.60	4.40
7	-11.05	-11.55		22	13.60	1.45
8	-11.05	-14.50		23	23.80	1.80
9	-26.50	-14.50		24	26.50	2.05
10	-26.50	-11.55		25	23.80	-0.70
11	-26.50	-6.05		26	26.50	-0.95
12	-26.50	-3.05		27	24.00	-5.30
13	-26.50	11.55		28	26.50	-5.30
14	-26.50	14.50		29	24.00	-8.30
15	-7.80	11.55		30	26.50	-8.30

r <del>-</del>	71.0000	<del></del>	
		00000 0 1 00	2X -#9.2000 THRU HOLE
		, , ,	<del></del>
30X ø1.4500	• •		FOR MOUNTING
PLATED THRU HOLE		MENDED PATTERN	

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS 6 AND 61 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
- 4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

## GENERIC MARKING DIAGRAM\*

XXXXX = Specific Device Code
G = Pb-Free Package

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

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